. .:eescale Semiconductor Technical Data

RF Power LDMOS Transistors High Ruggedness N-Channel

Enhancement-Mode Lateral MOSFETs

Designed for mobile two-way radio applications with frequencies from 764 to 941 MHz. The high gain, ruggedness and broadband performance of these devices make them ideal for large-signal, common source amplifier applications in mobile radio equipment.

Narrowband Performance (13.6 Vdc, I_{DQ} = 500 mA, T_A = 25°C, CW)

Frequency (MHz)	G _{ps} (dB)	η _D (%)	P1dB (W)
764	18.0	74.1	32
870	17.2	71.0	31
941	15.7	68.1	31

800 MHz Broadband Performance (13.6 Vdc, I_{DQ} = 100 mA, T_A = 25°C, CW)

Frequency (MHz)	G _{ps} (dB)	η _D (%)	P1dB (W)
760	15.7	62.0	44
820	15.7	63.0	37
870	15.5	61.0	36

Load Mismatch/Ruggedness

Frequency (MHz)	Signal Type	VSWR	P _{in} (W)	Test Voltage	Result
870 (1)	CW	>65:1 at all Phase Angles	1.2 (3 dB Overdrive)	17	No Device Degradation
870 (2)			2.0 (3 dB Overdrive)		

1. Measured in 870 MHz narrowband test circuit.

2. Measured in 760-870 MHz broadband reference circuit.

Features

- Characterized for Operation from 764 to 941 MHz
- Unmatched Input and Output Allowing Wide Frequency Range Utilization
- Integrated ESD Protection
- Integrated Stability Enhancements
- Wideband Full Power Across the Band (764-870 MHz)
- 225°C Capable Plastic Package
- Exceptional Thermal Performance
- High Linearity for: TETRA, SSB, LTE
- Cost-effective Over-molded Plastic Packaging
- In Tape and Reel. R1 Suffix = 500 Units, 24 mm Tape Width, 13 inch Reel.

Typical Applications

- Output Stage 800 MHz Trunking Band Mobile Radio
- Output Stage 900 MHz Trunking Band Mobile Radio

Document Number: AFT09MS031N Rev. 1, 8/2012

RoHS

AFT09MS031NR1 AFT09MS031GNR1

764-941 MHz, 31 W, 13.6 V WIDEBAND RF POWER LDMOS TRANSISTORS





Note: The backside of the package is the source terminal for the transistor.

Figure 1. Pin Connections





Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain-Source Voltage	V _{DSS}	-0.5, +40	Vdc
Gate-Source Voltage	V _{GS}	-6.0, +12	Vdc
Operating Voltage	V _{DD}	17, +0	Vdc
Storage Temperature Range	T _{stg}	-65 to +150	°C
Case Operating Temperature Range	T _C	-40 to +150	°C
Operating Junction Temperature Range (1,2)	TJ	-40 to +225	°C
Total Device Dissipation @ T _C = 25°C Derate above 25°C	P _D	317 1.59	W W/°C

Table 2. Thermal Characteristics

Characteristic	Symbol	Value ^(2,3)	Unit
Thermal Resistance, Junction to Case Case Temperature 81°C, 31 W CW, 13.6 Vdc, I _{DQ} = 500 mA, 870 MHz	$R_{ extsf{ heta}JC}$	0.63	°C/W

Table 3. ESD Protection Characteristics

Test Methodology	Class
Human Body Model (per JESD22-A114)	2, passes 2500 V
Machine Model (per EIA/JESD22-A115)	A, passes 100 V
Charge Device Model (per JESD22-C101)	IV, passes 1200 V

Table 4. Moisture Sensitivity Level

Test Methodology	Rating	Package Peak Temperature	Unit
Per JESD22-A113, IPC/JEDEC J-STD-020	3	260	°C

Table 5. Electrical Characteristics ($T_A = 25^{\circ}C$ unless otherwise noted)

Characteristic	Symbol	Min	Тур	Max	Unit
Off Characteristics					
Zero Gate Voltage Drain Leakage Current (V _{DS} = 40 Vdc, V _{GS} = 0 Vdc)	I _{DSS}	_	_	2	μAdc
Zero Gate Voltage Drain Leakage Current (V _{DS} = 13.6 Vdc, V _{GS} = 0 Vdc)	I _{DSS}	_	_	1	μAdc
Gate-Source Leakage Current (V _{GS} = 5 Vdc, V _{DS} = 0 Vdc)	I _{GSS}	_	_	600	nAdc
On Characteristics					
Gate Threshold Voltage (V _{DS} = 10 Vdc, I _D = 115 μAdc)	V _{GS(th)}	1.6	2.1	2.6	Vdc
Drain-Source On-Voltage (V _{GS} = 10 Vdc, I _D = 1.2 Adc)	V _{DS(on)}	_	0.1	—	Vdc
Forward Transconductance $(V_{GS} = 10 \text{ Vdc}, I_D = 10 \text{ Adc})$	9 _{fs}		7.8		S

1. Continuous use at maximum temperature will affect MTTF.

MTTF calculator available at <u>http://www.freescale.com/rf</u>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.

 Refer to AN1955, Thermal Measurement Methodology of RF Power Amplifiers. Go to <u>http://www.freescale.com/rf</u>. Select Documentation/Application Notes - AN1955.

(continued)



Table 5. Electrical Characteristics ($T_A = 25^{\circ}C$ unless otherwise noted) (continued)

>65:1 at all Phase Angles

CW

870

	Cł	aracteristic		Symbol	Min	Тур	Max	Unit
Dynamic Charac	cteristics							
Reverse Transf (V _{DS} = 13.6 V	fer Capacitance Vdc ± 30 mV(rms	s)ac @ 1 MHz, V _{GS} = 0 Vdc)		C _{rss}	—	2.1	-	pF
Output Capacit (V _{DS} = 13.6 V	ance Vdc ± 30 mV(rms	s)ac @ 1 MHz, V _{GS} = 0 Vdc)		C _{oss}	—	63	—	pF
Input Capacitar (V _{DS} = 13.6 V	nce Vdc, V _{GS} = 0 Vde	c ± 30 mV(rms)ac @ 1 MHz)		C _{iss}	_	140		pF
Functional Tests	s (1) (In Freescale	e Narrowband Test Fixture, 50	ohm system)	V _{DD} = 13.6	6 Vdc, I _{DQ} = 50	0 mA, P _{out}	= 31 W, f = 870) MHz
Common-Sour	ce Amplifier Pow	ver Gain		G _{ps}	16.0	17.2	18.5	dB
Drain Efficiency	/			η _D	68.0	71.0	_	%
Load Mismatch/I	Ruggedness (In	Freescale Test Fixture, 50 ohm	n system, I _{DQ}	= 500 mA)				
Frequency (MHz)	Signal Type	VSWR	P _{in} (W))	Test Voltage	e, V _{DD}	Resu	lt

 1. Measurement made with device in straight lead configuration before any lead forming operation is applied. Lead forming is used for gull wing (GN) parts.

1.2

17

No Device Degradation









Note: Measured with both sides of the transistor tied together.

Figure 3. Drain Current versus Drain-Source Voltage



MTTF calculator available at http://www.freescale.com/rf. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.





870 MHz NARROWBAND PRODUCTION TEST FIXTURE



Figure 5. AFT09MS031NR1 Narrowband Test Circuit Component Layout - 870 MHz

Part	Description	Part Number	Manufacturer
B1, B2	RF Beads, Long	2743021447	Fair-Rite
C1	3.9 pF Chip Capacitor	ATC100B3R9CT500XT	ATC
C2, C14, C15	56 pF Chip Capacitors	ATC100B560CT500XT	ATC
C3, C4, C5, C6	10 pF Chip Capacitors	ATC100B100JT500XT	ATC
C7, C8	3.6 pF Chip Capacitors	ATC100B3R6CT500XT	ATC
C9	2.5 μF Chip Capacitor	GRM31CR71H225KA88L	Murata
C10, C11	0.1 µF Chip Capacitors	C1206C104K1RAC-TU	Kemet
C12	10,000 pF Chip Capacitor	ATC200B103KT50XT	ATC
C13	22 μF, 25 V Tantalum Capacitor	TPSD226M025R0200	AVX
C16	330 μ F, 35 V Electrolytic Capacitor	MCGPR35V337M10X16-RH	Multicomp
L1	8.0 nH Inductor	A03TKLC	Coilcraft
L2	18.5 nH Inductor	A05TKLC	Coilcraft
L3	5.0 nH Inductor	A02TKLC	Coilcraft
РСВ	$0.030'', \epsilon_r = 3.5$	RO4350B	Rogers

Table 6. AFT09MS031NR1 Narrowband Test Circuit Component Designations a	and Values	— 870 MHz
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Figure 6. AFT09MS031NR1 Narrowband Test Circuit Schematic — 870 MHz

Description	Microstrip	Description
0″ Microstrip	6Z	0.190" × 0.080" Microstrip
0″ Microstrip	Z10	0.040" × 0.080" Microstrip
0″ Microstrip	Z11	0.454" × 0.520" Microstrip
5″ × 0.620″ Microstrip Taper	Z12	0.054" × 0.520" Microstrip
0" Microstrip	Z13	0.620" × 0.420" × 0.620" Microstrip Tape
0″ Microstrip	Z14	0.433" × 0.420" Microstrip
0″ Microstrip	Z15	0.665" × 0.420" Microstrip
0" Microstrip	Z16	0.200″ × 0.420″ Microstrip
	Microstrip Microstrip × 0.620" Microstrip Taper Microstrip Microstrip Microstrip	Microstrip Z10 Microstrip Z11 × 0.620" Microstrip Taper Z12 Microstrip Z13 Microstrip Z15 Microstrip Z16



TYPICAL CHARACTERISTICS — 870 MHz



Figure 7. CW Output Power versus Gate-Source Voltage



Figure 8. Power Gain, CW Output Power and Drain Efficiency versus Input Power



Figure 9. Narrowband Series Equivalent Source and Load Impedance — 870 MHz

7

760-870 MHz BROADBAND REFERENCE CIRCUIT

Table 8. 760-870 MHz Broadband Performance (In Freescale Reference Circuit, 50 ohm system) V_{DD} = 13.6 Volts, I_{DQ} = 100 mA, T_A = 25°C, CW Frequency MD P1dB (MHz) (dB) (%) (W)

Frequency (MHz)	G _{ps} (dB)	η _D (%)	P1dB (W)
760	15.7	62.0	44
820	15.7	63.0	37
870	15.5	61.0	36

Table 9. Load Mismatch/Ruggedness (In Freescale Reference Circuit)

Frequency (MHz)	Signal Type	VSWR	P _{in} (W)	Test Voltage, V _{DD}	Result
870	CW	>65:1 at all Phase Angles	2.0 (3 dB Overdrive)	17	No Device Degradation



760-870 MHz BROADBAND REFERENCE CIRCUIT



Figure 10. AFT09MS031NR1 Broadband Reference Circuit Component Layout - 760-870 MHz

Part	Description	Part Number	Manufacturer
C1, C10, C11, C12	5.6 pF Chip Capacitors	ATC600F5R6BT250XT	ATC
C2	6.8 pF Chip Capacitor	ATC600F6R8BT250XT	ATC
C3	8.2 pF Chip Capacitor	ATC600F8R2BT250XT	ATC
C4	12 pF Chip Capacitor	ATC600F120JT250XT	ATC
C5	10 pF Chip Capacitor	ATC600F100JT250XT	ATC
C6, C7	30 pF Chip Capacitors	ATC600F300JT250XT	ATC
C8, C9	22 pF Chip Capacitors	ATC600F220JT250XT	ATC
C13, C16, C17	240 pF Chip Capacitors	ATC600F241JT250XT	ATC
C14, C19	10 μF Chip Capacitors	GRM31CR61H106KA12L	Murata
C15, C18	1 μF Chip Capacitors	GRM21BR71H105KA12L	Murata
J1	3 Pin Connector	AMP-9-146305-0	TE Connectivity
L1	6.9 nH Inductor	0807SQ6N9	Coilcraft
Q1	RF Power LDMOS Transistor	AFT09MS031NR1	Freescale
R1	62 Ω Chip Resistor	RG2012N-620-B-T1	Susumu
РСВ	$0.020'', \epsilon_r = 4.8$	S1000-2	Shengyi

Table 10. AFT09MS031NR1	Broadband Reference	Circuit Compo	onent Designation	s and Values –	- 760-870 MHz





Figure 11. AFT09MS031NR1 Broadband Reference Circuit Schematic — 760-870 MHz

lable 11. A	FI09MS031NR1 Broadband	Reterence C	ircuit Microstrips — 760-8	00
Microstrip	Description	Microstrip	Description	_
Z1, Z20	0.034" × 0.060" Microstrip	Z11, Z12	0.390" × 0.120" Microstrip	r –
Z2*	0.034" × 0.380" Microstrip	Z13	0.390" × 0.080" Microstrip	
Z3*	0.034" × 0.215" Microstrip	Z14	0.034" × 0.100" Microstrip	
Z4	0.034" × 0.054" Microstrip	Z15	0.390" × 0.200" Microstrip	
Z5, Z6	0.266" × 0.025" Microstrip	Z16	0.034″ × 0.110″ Microstrip	
Z7, Z9	0.266" × 0.080" Microstrip	Z17	0.034" × 0.010" Microstrip	
Z8	0.034" × 0.050" Microstrip	Z18*	0.034" × 0.190" Microstrip	r –
Z10	0.266" × 0.015" Microstrip	Z19*	0.034″ × 0.110″ Microstrip	
* Line length	includes microstrip bends			1

370 MHz

NP

TYPICAL CHARACTERISTICS — 760-860 MHz BROADBAND REFERENCE CIRCUIT



Figure 12. Power Gain, CW Output Power and Drain Efficiency versus Frequency at a Constant Input Power







TYPICAL CHARACTERISTICS — 760-870 MHz BROADBAND REFERENCE CIRCUIT



Figure 14. CW Output Power versus Gate-Source Voltage







760-870 MHz BROADBAND REFERENCE CIRCUIT



f MHz	Z _{source} Ω	Z _{load} Ω
760	0.85 - j1.31	0.80 - j0.92
770	0.80 - j1.30	0.78 - j0.88
780	0.75 - j1.28	0.78 - j0.85
790	0.69 - j1.26	0.76 - j0.81
800	0.65 - j1.24	0.76 - j0.78
810	0.59 - j1.21	0.72 - j0.75
820	0.55 - j1.18	0.70 - j0.73
830	0.51 - j1.15	0.67 - j0.70
840	0.46 - j1.11	0.62 - j0.66
850	0.42 - j1.01	0.57 - j0.62
860	0.39 - j1.02	0.52 - j0.57
870	0.36 - j0.97	0.48 - j0.52

 V_{DD} = 13.6 Vdc, I_{DQ} = 100 mA, P_{out} = 31 W Avg.

 Z_{source} = Test circuit impedance as measured from gate to ground.





Figure 14. Broadband Series Equivalent Source and Load Impedance — 760-870 MHz



PACKAGE DIMENSIONS



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		CASE NUMBER: 1265-09 29 JUN 2007		
SON ACE MOON	I	STANDARD: JE	DEC TO-270 AA	



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TITLE:		DOCUMENT NO	REV: K	
SURFACE MOUN	т	CASE NUMBER: 1265-09 29 JUN 200		
SURFACE MOUNT		STANDARD: JE	DEC TO-270 AA	



NOTES:

- 1. CONTROLLING DIMENSION: INCH
- 2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
- 3. DATUM PLANE -H- IS LOCATED AT TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
- 4. DIMENSIONS "D1" AND "E1" DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 PER SIDE. DIMENSIONS "D1 AND "E1" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -H-.
- DIMENSION "b1" DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 TOTAL IN EXCESS OF THE "b1" DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 6. DATUMS -A- AND -B- TO BE DETERMINED AT DATUM PLANE -H-.
- 7. DIMENSION "A2" APPLIES WITHIN ZONE "J" ONLY.
- 8. DIMENSIONS "D" AND "E2" DO NOT INCLUDE MOLD PROTRUSION. OVERALL LENGTH INCLUDING MOLD PROTRUSION SHOULD NOT EXCEED 0.430 INCH FOR DIMENSION "D" AND 0.080 INCH FOR DIMENSION "E2". DIMENSIONS "D" AND "E2" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -D-.

	IN	ICH	MIL	LIMETER			INCH	М	ILLIMETER
DIM	MIN	MAX	MIN	MAX	DIM	MIN	MAX	MIN	MAX
A	.078	.082	1.98	2.08	F	.0	25 BSC	0	0.64 BSC
A1	.039	.043	0.99	1.09	b1	.193	.199	4.90	5.06
A2	.040	.042	1.02	1.07	c1	.007	.011	0.18	3 0.28
D	.416	.424	10.57	10.77	aaa		.004		0.10
D1	.378	.382	9.60	9.70					
D2	.290		7.37						
D3	.016	.024	0.41	0.61					
E	.436	.444	11.07	11.28					
E1	.238	.242	6.04	6.15					
E2	.066	.074	1.68	1.88					
E3	.150		3.81						
E4	.058	.066	1.47	1.68					
E5	.231	.235	5.87	5.97					
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	50	REAUE I	NUOUN		STAN	DARD: JE	DEC TO-270 /	٩A	

STYLE 1: PIN 1 - DRAIN PIN 2 - GATE PIN 3 - SOURCE



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TITLE:		DOCUMENT NO): 98ASA99301D	REV: C
		CASE NUMBER	02 JUL 2007	
GOLL WING		STANDARD: JE	DEC TO-270 BA	-

NP

NOTES:

- 1. CONTROLLING DIMENSION: INCH
- 2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
- 3. DATUM PLANE -H- IS LOCATED AT TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
- 4. DIMENSIONS "D1" AND "E1" DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 PER SIDE. DIMENSIONS "D1 AND "E1" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -H-.
- 5. DIMENSION 61 DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 TOTAL IN EXCESS OF THE 61 DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 6. DATUMS -A- AND -B- TO BE DETERMINED AT DATUM PLANE -H-.
- 7. DIMENSIONS "D" AND "E2" DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .003 PER SIDE. DIMENSIONS "D AND "E2" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -D-.

STYLE 1:			
PIN	1	_	DRAIN
PIN	2	—	GATE
PIN	3	—	SOURCE

	INCH		MILLIMETER				INCH		MILLIMETER	
DIM	MIN	MAX	MIN	MAX	DIM	MIN	MAX	MIN	MAX	
A	.078	.082	1.98	2.08	L	.018	.024	0.46	5 0.61	
A1	.001	.004	0.02	0.10	L1		.01 BSC		0.25 BSC	
A2	.077	.088	1.96	2.24	b1	.193	.199	4.90	5.06	
D	.416	.424	10.57	10.77	c1	.007	.011	0.18	3 0.28	
D1	.378	.382	9.60	9.70	e	2*	8'	2.	8.	
D2	.290	-	7.37	—	مەم		.004		0.10	
D3	.016	.024	0.41	0.61						
Е	.316	.324	8.03	8.23						
E1	.238	.242	6.04	6.15						
E2	.066	.074	1.68	1.88						
E3	.150	—	3.81	_						
E4	.058	.066	1.47	1.68						
E5	.231	.235	5.87	5.97						
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					CASE NUMBER: 1265A-03			02 JUL 2007		
GULL WIING						STANDARD: JEDEC TO-270 BA				



PRODUCT DOCUMENTATION, SOFTWARE AND TOOLS

Refer to the following documents, software and tools to aid your design process.

Application Notes

- AN1907: Solder Reflow Attach Method for High Power RF Devices in Over-Molded Plastic Packages
- AN1955: Thermal Measurement Methodology of RF Power Amplifiers
- AN3263: Bolt Down Mounting Method for High Power RF Transistors and RFICs in Over-Molded Plastic Packages
- · AN3789: Clamping of High Power RF Transistors and RFICs in Over-Molded Plastic Packages

Engineering Bulletins

EB212: Using Data Sheet Impedances for RF LDMOS Devices

Software

- Electromigration MTTF Calculator
- RF High Power Model
- .s2p File

Development Tools

• Printed Circuit Boards

For Software and Tools, do a Part Number search at http://www.freescale.com, and select the "Part Number" link. Go to the Software & Tools tab on the part's Product Summary page to download the respective tool.

REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
0	May 2012	Initial Release of Data Sheet
1	Aug. 2012	 Load Mismatch/Ruggedness tables: changed output power to input power to clarify the conditions used during test, p. 1, 8 Fig. 10, Broadband Reference Circuit Component Layout — 760-870 MHz: added C18 and C19; replaced L1 with R1 and L2 with L1, p. 9 Table 10, Broadband Reference Circuit Component Designations and Values — 760-870 MHz: changed C14 description from 0.10 μF to 10 μF and part number from GRM21BR71H104KA01B to GRM31CR61H106KA12L; changed C15 description from 0.01 μF to 1 μF and part number from GRM21BR72A103KA01B to GRM21BR71H105KA12L; changed C17 description from 22 pF to 240 pF and part number from ATC100A220JT150XT to ATC600F241JT250XT; added C18 and C19; replaced L1 with R1 and L2 with L1, p. 9 Fig. 11, Broadband Reference Circuit Schematic — 760-870 MHz: added C18 and C19; replaced L1 with R1 and L2 with L1, p. 10 Modifications to Fig. 10, Table 10 and Fig. 11 will improve stability of the test circuit and improve performance under a modulated signal, p. 9, 10



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